

**Search Notes**

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Applicant(s)/Patent under  
Reexamination

KIM, JIN K.

Art Unit

2821

**SEARCHED**

Class	Subclass	Date	Examiner
372	43.01- 46.016	11/21/2005	LA

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST prior art text search (see "Examiner Search Notes")	11/21/2005	LA